



* PATENT APPLICATION
Page 1 of 2

FORM PTO-1449	ATTY. DKT NO. VX032571	SER. NO. 10/766,470
	APPLICANT FUKAZAWA et al.	
	FILING DATE November 21, 2006	GROUP

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>JRS</i>	6,098,739	8/2000	Anderson et al.		
	6,138,786	10/2000	Anderson et al.		
	4,342,470	8/1982	Matsuda		
	6,293,364	9/2001	Anderson et al.		
	5,568,841	10/1996	Weissbach		
	2002/0139601	10/2002	Nagatsuka		
	4,726,440	2/1998	Kamlukin et al.		
	6,575,262	6/2003	Nagatsuka		
	4,514,007	4/1985	Macht		
	6,167,980	1/2001	Anderson et al.		
	2004/0026153	2/2004	Dershem et al.		
<i>JRS</i>	2006/0001250	1/2006	Fuzazawa et al.		

EXAMINER <i>Jorge R. Sandoval</i>	DATE CONSIDERED <i>3/16/07</i>
--------------------------------------	-----------------------------------

Rev. 10/94 (Form 3.05)

FORM PTO-1449	ATTY. DKT NO.	VX032571	SER. NO.	10/766,470
	APPLICANT	FUKAZAWA et al.		
	FILING DATE	November 21, 2006		GROUP

FOREIGN PATENT DOCUMENTS

TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
									Eng. Abstract
<i>JP03</i>	JP 03-63327	3/19/91	JAPAN						X
<i>JP02</i>	JP-02-88877	7/13/90	JAPAN						X
<i>JP55</i>	JP S55-152674 A	11/28/80	JAPAN						X

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER
George D. Smith
 Rev. 10/94 (Form 3.05)

DATE CONSIDERED

3/16/07